

MAXIMUM RATINGS

Rating	Symbol	Value	Unit
Collector-Emitter Voltage	V_{CEO}	15	Vdc
Collector-Emitter Voltage(1)	V_{CER}	20	Volts
Collector-Base Voltage	V_{CBO}	25	Volts
Emitter-Base Voltage	V_{EBO}	5.0	Volts
Collector Current	I_C	50	mA
Total Device Dissipation at $T_A = 25^\circ\text{C}$ Derate above 25°C	P_D	0.3 2.0	Watt mW°C
Total Device Dissipation at $T_C = 25^\circ\text{C}$ Derate above 25°C	P_D	1.0 5.7	Watts mW°C
Total Device Dissipation at $T_C = 100^\circ\text{C}$ Derate above 100°C	P_D	0.5	Watt
Operating and Storage Junction Temperature Range	T_J, T_{Stg}	65 to +200	C

THERMAL CHARACTERISTICS

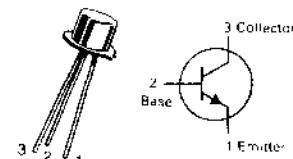
Characteristic	Symbol	Max	Unit
Thermal Resistance, Junction to Ambient	R_{JA}	500	$^\circ\text{C/W}$
Thermal Resistance, Junction to Case	R_{JC}	175	$^\circ\text{C/W}$

ELECTRICAL CHARACTERISTICS ($T_A = 25^\circ\text{C}$ unless otherwise noted.)

Characteristic	Symbol	Min	Max	Unit
OFF CHARACTERISTICS				
Collector-Emitter Breakdown Voltage(2) ($I_C = 10 \text{ mA}_\text{dc}, I_B = 0$)	$V_{(\text{BR})\text{CEO}}$	15	—	Vdc
Collector-Emitter Breakdown Voltage(2) ($I_R = 10 \text{ ohms}, I_C = 10 \text{ mA}_\text{dc}$)	$V_{(\text{BR})\text{CER}}$	20	—	Vdc
Collector Cutoff Current ($V_{CB} = 15 \text{ Vdc}, I_E = 0$) ($V_{CB} = 15 \text{ Vdc}, I_E = 0, T_A = 150^\circ\text{C}$) ($V_{CB} = 25 \text{ Vdc}, I_E = 0$)	I_{CBO}	— — —	0.5 30 10	μA_dc
Collector Cutoff Current ($V_{CE} = 20 \text{ Vdc}, R_{BE} = 100\text{k}$)	I_{CER}	—	10	μA_dc
Emitter Cutoff Current ($V_{EB} = 5.0 \text{ Vdc}, I_C = 0$)	I_{EBO}	—	10	μA_dc
ON CHARACTERISTICS				
DC Current Gain (2) ($I_C = 10 \text{ mA}_\text{dc}, V_{CE} = 1.0 \text{ Vdc}$)	h_{FE}	20	60	—
Collector-Emitter Saturation Voltage(2) ($I_C = 10 \text{ mA}_\text{dc}, I_E = 1.0 \text{ mA}_\text{dc}$)	$V_{CE(\text{sat})}$	—	0.6	Vdc
Base-Emitter Saturation Voltage(2) ($I_C = 10 \text{ mA}_\text{dc}, I_B = 1.0 \text{ mA}_\text{dc}$)	$V_{BE(\text{sat})}$	0.7	0.9	Vdc
SMALL-SIGNAL CHARACTERISTICS				
Current-Gain — Bandwidth Product ($V_{CE} = 15 \text{ Vdc}, I_E = 10 \text{ mA}_\text{dc}, f = 100 \text{ MHz}$)	f_T	200	—	MHz
Output Capacitance ($V_{CB} = 5.0 \text{ Vdc}, I_E = 0, f = 1 \text{ MHz}$)	C_{obo}	—	5.0	μF
Magnitude of Forward Current Transfer Ratio, Common-Emitter ($V_{CE} = 10 \text{ Vdc}, I_E = 10 \text{ mA}_\text{dc}, f = 100 \text{ MHz}$)	$ h_{fe} $	2.0	—	—

2N706A

CASE 22-03, STYLE 1
TO-18 (TO-206AA)



SWITCHING TRANSISTOR

NPN SILICON

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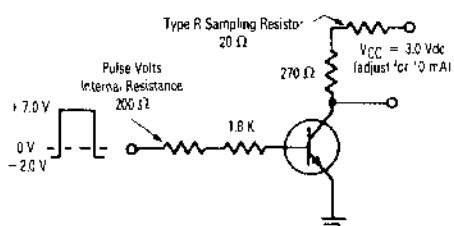
Refer to 2N2369 for graphs.

ELECTRICAL CHARACTERISTICS (continued) ($T_A = 25^\circ\text{C}$ unless otherwise noted.)

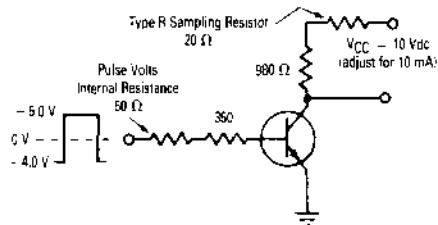
Characteristic	Symbol	Min	Max	Unit
Collector Base Time Constant ($V_{CE} = 15 \text{ Vdc}$, $I_E = 10 \text{ mAdc}$, $f = 300 \text{ MHz}$)	r_b	—	50	ohms
Turn-On Time ($I_{B1} = 3.0 \text{ mA}$, $I_{B2} = 1.0 \text{ mA}$)	t_{on}	—	40	ns
Turn-Off Time ($I_{B1} = 3.0 \text{ mA}$, $I_{B2} = 1.0 \text{ mA}$)	t_{off}	—	75	ns
Charge Storage Time Constant(2)	τ_s	—	25	ns

(1) Refers to collector breakdown voltage in the high current region when $R_{be} = 10 \Omega$.(2) Pulse Test: Pulse Width $\leq 300 \mu\text{s}$, Duty Cycle $\leq 2.0\%$.(3) Switching Times Measured with Tektronix Type R Plug-In (50 Ω Internal Impedance).

SWITCHING TIME TEST CIRCUIT



STORAGE TIME TEST CIRCUIT



MEASUREMENT CIRCUIT

